

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Fixed capacitors for use in electronic equipment –
Part 1: Generic specification**

**Condensateurs fixes utilisés dans les équipements électroniques –
Partie 1: Spécification générique**

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CONTENTS

FOREWORD.....	9
INTRODUCTION.....	11
1 General.....	13
1.1 Scope	13
1.2 Normative references	13
2 Technical data.....	15
2.1 Symbols, units and abbreviated terms	15
2.1.1 General	15
2.1.2 Letter symbols	15
2.1.3 Abbreviations	16
2.2 Terms and definitions	16
2.3 Preferred values and additional technical requirements.....	21
2.3.1 General	21
2.3.2 Preferred values of nominal capacitance	21
2.3.3 Preferred values of rated voltage.....	21
2.3.4 Rated a.c. load	21
2.3.5 Rated pulse load	22
2.3.6 Temperature derated voltage.....	22
2.4 Marking.....	23
2.4.1 General	23
2.4.2 Coding.....	23
3 Quality assessment procedures	23
4 Tests and measurement procedures.....	24
4.1 General.....	25
4.2 Standard atmospheric conditions	25
4.2.1 Standard atmospheric conditions for testing.....	25
4.2.2 Recovery conditions.....	25
4.2.3 Referee conditions	26
4.2.4 Reference conditions	26
4.3 Drying.....	26
4.4 Visual examination and check of dimensions	26
4.4.1 Visual examination.....	26
4.4.2 Dimensions (gauging)	26
4.4.3 Dimensions (detail)	26
4.5 Insulation resistance	27
4.5.1 Preconditioning	27
4.5.2 Measuring conditions	27
4.5.3 Test points.....	27
4.5.4 Test methods.....	27
4.5.5 Temperature compensation	28
4.5.6 Conditions to be prescribed in the relevant specification	28
4.6 Voltage proof	29
4.6.1 General	29
4.6.2 Test circuit (for the test between terminations).....	29
4.6.3 Test.....	30
4.6.4 Requirements	32

4.6.5	Conditions to be prescribed in the relevant specification	32
4.7	Capacitance	32
4.7.1	Measuring frequency and measuring voltage	32
4.7.2	Measuring equipment	33
4.7.3	Conditions to be prescribed in the relevant specification	33
4.8	Tangent of loss angle and equivalent series resistance (ESR)	33
4.8.1	Tangent of loss angle	33
4.8.2	Equivalent series resistance (ESR)	33
4.9	Leakage current	34
4.9.1	Preconditioning	34
4.9.2	Test method	34
4.9.3	Power source	34
4.9.4	Measuring accuracy	34
4.9.5	Test circuit	34
4.9.6	Conditions to be prescribed in the relevant specification	34
4.10	Impedance	34
4.11	Self-resonant frequency and inductance	35
4.11.1	Self-resonant frequency (f_r)	35
4.11.2	Inductance	38
4.11.3	Conditions to be prescribed in the relevant specification	38
4.12	Outer foil termination	38
4.13	Robustness of terminations	39
4.13.1	General	39
4.13.2	Test Ua ₁ – Tensile	39
4.13.3	Test Ub – Bending (half of the sample)	40
4.13.4	Test Uc – Torsion (remaining sample)	40
4.13.5	Test Ud – Torque	40
4.13.6	Visual examination	40
4.14	Resistance to soldering heat	41
4.14.1	Preconditioning and initial measurement	41
4.14.2	Test procedure	41
4.14.3	Recovery	41
4.14.4	Final inspection, measurement and requirements	41
4.15	Solderability	41
4.15.1	General	41
4.15.2	Preconditioning	41
4.15.3	Test procedure	42
4.15.4	Final inspection, measurements and requirements	42
4.16	Rapid change of temperature	42
4.16.1	Initial measurement	42
4.16.2	Test procedure	42
4.16.3	Final inspection, measurements and requirements	42
4.17	Vibration	42
4.17.1	Initial measurement	42
4.17.2	Test procedure	43
4.17.3	Electrical test (intermediate measurement)	43
4.17.4	Final inspection, measurements and requirements	43
4.18	Bump (repetitive shock)	43
4.18.1	Initial measurement	43

4.18.2	Test procedure.....	43
4.18.3	Final inspection, measurements and requirements.....	43
4.19	Shock	43
4.19.1	Initial measurement.....	43
4.19.2	Test procedure.....	43
4.19.3	Final inspection, measurements and requirements.....	44
4.20	Container sealing	44
4.21	Climatic sequence.....	44
4.21.1	General	44
4.21.2	Initial measurements	44
4.21.3	Dry heat.....	44
4.21.4	Damp heat, cyclic, Test Db, first cycle	44
4.21.5	Cold.....	44
4.21.6	Low air pressure	45
4.21.7	Damp heat, cyclic, Test Db, remaining cycles	45
4.21.8	Final measurements.....	45
4.22	Damp heat, steady state.....	45
4.22.1	Initial measurement.....	45
4.22.2	Test procedure.....	45
4.22.3	Final inspection, measurements and requirements.....	46
4.23	Endurance	46
4.23.1	Initial measurements	46
4.23.2	Test procedure.....	46
4.23.3	Conditions to be prescribed in the relevant specification	46
4.23.4	Test voltage.....	46
4.23.5	Placement in the test chamber	47
4.23.6	Recovery	47
4.23.7	Final inspection, measurements and requirements.....	47
4.24	Variation of capacitance with temperature.....	48
4.24.1	Static method.....	48
4.24.2	Dynamic method	48
4.24.3	Methods of calculation	49
4.25	Storage.....	50
4.25.1	Storage at high temperature	50
4.25.2	Storage at low temperature	50
4.26	Surge.....	51
4.26.1	Initial measurement.....	51
4.26.2	Test procedure.....	51
4.26.3	Final inspection, measurements and requirements.....	52
4.26.4	Information to be given in the relevant detail specification.....	52
4.27	Charge and discharge tests and inrush current test.....	52
4.27.1	Initial measurement.....	52
4.27.2	Test procedure.....	52
4.27.3	Charge and discharge	53
4.27.4	Inrush current	54
4.27.5	Final inspection, measurements and requirements.....	54
4.28	Pressure relief (for aluminium electrolytic capacitors).....	54
4.28.1	General	54
4.28.2	AC test	54

4.28.3	DC test	54
4.28.4	Pneumatic test	54
4.28.5	Final inspection, measurements and requirements	54
4.29	Characteristics at high and low temperature	54
4.29.1	Test procedure	54
4.29.2	Requirements	55
4.30	Thermal stability test	55
4.31	Component solvent resistance	55
4.31.1	Initial measurements	55
4.31.2	Test procedure	55
4.31.3	Final inspection, measurements and requirements	55
4.32	Solvent resistance of marking	55
4.32.1	Test procedure	55
4.32.2	Final inspection, measurements and requirements	56
4.33	Mounting (for surface mount capacitors only)	56
4.33.1	Substrate	56
4.33.2	Wave soldering	56
4.33.3	Reflow soldering	56
4.34	Shear test	59
4.34.1	Test procedure	59
4.34.2	Final inspection, measurements and requirements	59
4.35	Substrate bending test	59
4.35.1	Test procedure	59
4.35.2	Recovery	60
4.35.3	Final inspection and requirements	60
4.36	Dielectric absorption	60
4.36.1	Test procedure	60
4.36.2	Requirement	61
4.37	Damp heat, steady state, accelerated	61
4.37.1	Initial measurements	61
4.37.2	Test methods	61
4.37.3	Test procedures	61
4.37.4	Final inspection, measurements and requirements	61
4.38	Passive flammability	61
4.38.1	Test procedure	61
4.38.2	Final inspection, measurements and requirements	62
4.39	High surge current test	62
4.39.1	Initial measurements	62
4.39.2	Test procedure	62
4.39.3	Requirements for the charging circuit	63
4.39.4	Nonconforming items	63
4.40	Voltage transient overload (for aluminium electrolytic capacitors with non-solid electrolyte)	63
4.40.1	Initial measurement	63
4.40.2	Test procedure	63
4.40.3	Final inspection, measurements and requirements	65
4.40.4	Conditions to be prescribed in the relevant specification	65
4.41	Whisker growth test	65
4.41.1	General	65

4.41.2	Preparation of specimen.....	66
4.41.3	Initial measurement.....	66
4.41.4	Test procedures	66
4.41.5	Test severities	66
4.41.6	Final inspection, measurements and requirements.....	66
Annex A (informative) Interpretation of sampling plans and procedures as described in IEC 60410 for use within quality assessment systems.....		67
Annex B (informative) Rules for the preparation of detail specifications for capacitors and resistors for electronic equipment for use within quality assessment systems		68
B.1	Drafting.....	68
B.2	Reference standard.....	68
B.3	Circulation	68
Annex C (informative) Layout of the first page of a PCP/CQC specification		69
Annex D (informative) Requirements for capability approval test report		70
D.1	General.....	70
D.2	Requirements.....	70
D.3	Summary of test information (for each CQC).....	70
D.4	Measurement record	70
Annex E (informative) Guide for pulse testing of capacitors.....		71
E.1	Overview.....	71
E.2	Typical capacitor pulse conditions	71
E.3	Effect of inductance on pulse testing	72
Annex F (informative) Guidance for the extension of endurance tests on fixed capacitors.....		74
F.1	Overview.....	74
F.2	Guidelines.....	74
Annex G (normative) Damp heat, steady state with voltage applied, for metallized film capacitors only		75
G.1	Overview.....	75
G.2	Test procedure.....	75
Annex H (normative) Accelerated damp heat, steady state, for multilayer ceramic capacitors only		76
H.1	Mounting of capacitors	76
H.2	Initial measurement.....	76
H.3	Test procedure.....	76
H.4	Recovery	76
H.5	Final inspection, measurements and requirements.....	76
Annex Q (informative) Quality assessment procedures		77
Q.1	General.....	77
Q.1.1	Scope of this annex	77
Q.1.2	Quality assessment definitions	78
Q.1.3	Rework	78
Q.1.4	Alternative test methods.....	79
Q.1.5	Certified test records of released lots	79
Q.1.6	Unchecked parameters	79
Q.1.7	Delayed delivery	79
Q.1.8	Repair	79
Q.1.9	Registration of approvals.....	80
Q.1.10	Manufacture outside the geographical limits	80

Q.2	Qualification approval (QA) procedures	80
Q.2.1	Eligibility for qualification approval.....	80
Q.2.2	Application for qualification approval	80
Q.2.3	Subcontracting.....	80
Q.2.4	Test procedure for the initial product qualification approval	80
Q.2.5	Granting of qualification approval	80
Q.2.6	Maintenance of qualification approval.....	81
Q.2.7	Quality conformance inspection.....	81
Q.3	Capability approval (CA) procedures.....	81
Q.3.1	General	81
Q.3.2	Eligibility for capability approval	81
Q.3.3	Application for capability approval	82
Q.3.4	Subcontracting.....	82
Q.3.5	Description of the capability	82
Q.3.6	Demonstration and verification of capability	82
Q.3.7	Granting of capability approval	82
Q.3.8	Maintenance of capability approval.....	82
Q.3.9	Quality conformance inspection.....	82
Q.4	Technology approval (TA) procedure	83
Q.4.1	General	83
Q.4.2	Eligibility for technology approval	83
Q.4.3	Application of technology approval	83
Q.4.4	Subcontracting.....	83
Q.4.5	Description of technology	83
Q.4.6	Demonstration and verification of the technology	83
Q.4.7	Granting of technology approval.....	84
Q.4.8	Maintenance of technology approval.....	84
Q.4.9	Quality conformance inspection.....	84
Bibliography		85
Figure 1	– Reactive power against frequency	22
Figure 2	– Relation between category temperature range and applied voltage.....	23
Figure 3	– Voltage-proof test circuit.....	30
Figure 4	– Schematic diagram of the impedance measuring circuit.....	35
Figure 5	– Capacitor mounting arrangement	36
Figure 6	– Capacitor mounting arrangement	37
Figure 7	– Typical diagram of an absorption oscillator-wavemeter.....	37
Figure 8	– Schematic diagram of the measuring circuit	38
Figure 9	– Test circuit	39
Figure 10	– Test circuit for electrolytic capacitors	47
Figure 11	– Relay circuit	51
Figure 12	– Thyristor circuit	51
Figure 13	– Voltage waveform across capacitor.....	52
Figure 14	– Voltage and current waveform	53
Figure 15	– Suitable substrate for mechanical tests	58
Figure 16	– Suitable substrate for electrical tests.....	59

Figure 17 – High surge current test	63
Figure 18 – Voltage transient overload test circuit	64
Figure 19 – Voltage waveform.....	65
Table 1 – Referee conditions.....	26
Table 2 – Measurement of insulation resistance	27
Table 3 – Measuring points	29
Table 4 – Tensile force	40
Table 5 – Torque	40
Table 6 – Number of cycles.....	45
Table 7 – Severities and requirements	62